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# **EMC TEST REPORT For FCC**

Test Report No. : CTK03-F083

Date of Issue : August 5, 2003

FCC ID : MSAD19BL-1

Model/Type No. : D19BL

Kind of Product : CRT Monitor

Applicant : Hansol LCD Inc.

Applicant Address : 27-29, Hanchon-Ri, Ducksan-Myun, Jinchon-Gun, Chungbuk,

365-840, Korea

Manufacturer : Hansol Electronics (Thailand) Co., LTD.

Manufacturer Address : 168 Moo 1 Tambon Banbung, Amphoe Banbung, Chonburi

Province 20170 Thailand

Contact Person : Mr. Weon Seo, LEE

Telephone : +82-43-530-8554

Received Date : July 25, 2003

Test period : Start: July 26, 2003 End: July 26, 2003

Test Results : In Compliance Not in Compliance

The test results presented in this report relate only to the object tested.

CERTITEK Standards Laboratory Co., Ltd. is accredited by Korea Laboratory Accreditation Scheme (KOLAS) which signed the International Laboratory Accreditation Cooperation (ILAC) Mutual Recognition Arrangement (MRA) for the above test item(s) and test method(s).

Tested by

Young Joon, Park EMC Test Engineer
Date: August 5, 2003

Reviewed by

James Hong

EMC Technical Manager Date: August 5, 2003

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# REPORT REVISION HISTORY

Date	Revision	Page No
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# 1.0 General Product Description

# 1.0.1 Tested Equipment

	$\boxtimes$	Unless otherwise indicated, all tests were conducted on Model D19BL.						
		Tests p	erformed on Modelentative of Model(s)					
1.0.2	Equip	ment S	Size, Mobility and Identifica	ation				
	Mobility	y:	440(W) by 454(D) by 447(H) ☐ Hand-Held ☐ Table-top Not Applicable					
1.0.3	Electr	ical Ra	tings					
	•		AC 100-240V, 50/60Hz ± 3Hz Not applicable					
1.0.4	Test \	/oltage	e & Frequency					
			d otherwise on the individual da equency was as indicated below	ata sheet or test results, the test				
	_	e: ncy:	120VAC 60Hz					

# 1.0.5 Clock & Other Frequencies Utilized

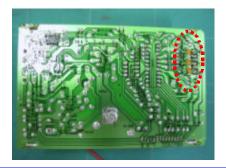
12MHz

# 1.1 Model Differences

Not applicable

# 1.2 Device Modifications

Three capacitors [47pF/C41, C42 and C43] will be added in VIDEO BOARD as below photo;



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# 1.3 EUT Configuration(s)

See Appendix A for individual test set-up configuration(s). The following peripheral devices and/or interface cables were connected during the measurement:

Peripheral Devices

Device	Manufacturer	Model No.	Serial No.	DoC or TCB (ID)
PC	Hewlett-Packard Company	HP PD1059	n/a	DoC
KEYBOARD	SAMSUNG	SEM-DT35	33008109	DoC
MOUSE (PS/2 type)	SAMSUNG	OMS3CB	0303009871	DoC
MOUSE (USB type)	SAMSUNG	OMC3CB	0303009883	DoC
MOUSE (Serial type)	Microsoft	BASM1	4475951-20000	DoC

## 

#	Description	Ferrited	Length (m)	Other Details
1	AC Power, Unshielded	No	1.8	Connect to AC Power from EUT
2	AC Power, Unshielded	No	1.8	Connect to AC Power from PC
3	Monitor cable, Shielded	Yes	1.8	Connect to PC
4	Keyboard cable, Shielded	No	2.0	n/a
5	Mouse cable, Shielded	No	2.0	PS/2 Type
6	Mouse cable, Shielded	No	2.0	USB Type
7	Mouse cable, Shielded	No	2.0	Serial Type

n/a = not available

# 1.4 Test Software □ Pinging □ Name / Version / Type of Pattern : Display Test Patterns / 1.5 / Scrolling 'H' 1.5 EUT Operating Mode(s) Equipment under test was operated during the measurement under the following conditions: □ Test program (Scrolling 'H') □ Test program (color bar) □ Standby □ Practice operation □ Resolution / Refresh Rate - 1600 x 1200 / 75Hz

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# 1.6 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

# 1.7 Test Facility

The measurement facility is located at 386-1, Ho-Dong, Yongin-City, Kyungki-Do, Korea 449-100. The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22.

## 1.8 Measurement Procedure

Preliminary AC power line conducted emissions tests were performed shielded room. To find worst mode, several typical mode and typical cable position were tested. Final AC power line conducted emissions test was performed shielded room. (location is same as Preliminary test)

Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

Preliminary radiated emissions test were performed anechoic chamber (Distance of antenna and EUT was 3 m). To find worst mode, several typical mode and typical cable position were tested and peak level and frequency were recorded.

Final radiated emissions test was performed Open Area Test Site. Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

\* Measurement procedures was In accordance with ANSI C63.4-1992 7.2.3, 7.2.4, 8.3.1.1, 8.3.1.2

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### 1.9 **Laboratory Accreditations and Listings**

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 and 10 meter Open Area Test Sites to perform FCC Part 15/18 measurements.	FC 93250
JAPAN	VCCI	10 meter Open Area Test Site and one conducted site.	<b>P</b> -948, C-986
KOREA	MIC	10 meter Open Area Test Site and EMS (ESD, RS, EFT/Burst, Surge)	MIC No. 51, KR0025
International	KOLAS	EMC	KOLAS POR NO.118
Europe	GLAS	EMC EN 55011, EN 55022, EN 55024, EN 61326, EN 50130-4, EN 50081-1, EN 50081-2, EN 50082-1, EN 50082-2, EN 61000-6-2, EN 61000-4-2, EN 61000-4-3, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, EN 61000-4-8, EN 61000-3-3	<b>TÜV</b> No.13000796-02

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## **Emissions Test Regulations** 2.0

The emissions tests were performed according	The emissions tests were performed according to following regulations:					
☐ EN 50081-1:1992						
☐ EN 55011:1998 +A1:1999	Group 1 Class A	Group 2 Class B				
☐ EN 55013:1990 +A12:1994 +A13:1996 +A14☐ EN 55013:2001	1:1999					
☐ EN 55014-1:1993 +A1:1997 +A2:1999	☐ Household appliance☐ Portable tools☐ Semiconductor dev					
☐ EN 55014-1:2000 ☐ EN 55014-2:1997						
☐ EN 55015:1996 +A1:1997 +A2:1999 ☐ EN 55015:2000						
☐ EN 55020:1994 +A11:1996 +A13:1999 +A14☐ EN 55020:1994 +A11:1996 +A12:1999 +A13						
☐ EN 55022:1994 +A1:1995 +A2:1997 ☐ EN 55022:1998 +A1:2000	☐ Class A ☐ Class A	Class B Class B				
☐ EN 61000-3-2:1995 +A1:1998 +A2:1998 ☐ EN 61000-3-2:1995 +A1:1998 +A2:1998 +A ☐ EN 61000-3-2:2000 ☐ EN 61000-3-3:1995	14:2000					
☐ VCCI V-3/99.05 : 1999	☐ Class A	☐ Class B				
☐ FCC PART 15 Subpart B	☐ Class A	⊠ Class B				
☐ AS 3548 (1992)	☐ Class A	☐ Class B				

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# 2.1 Conducted Voltage Emissions

## **Test Date**

July 26, 2003

Test Location EMI-CE: Shielded Room			
Test Instruments  ☑ Field Strength Meter	r Rohde & Schwarz	ESHS30	828144/002
Test Accessories  ☐ LISN  ☒ LISN  ☒ LISN ☒ Control PC	EMCO EMCO EMCO HP	3825/2 3825/2 3825/2 Vectra 500	9607-2574
Frequency Range o  150 kHz to 30 MHz  450 kHz to 30 MHz	f Measurement		
Instrument Setting IF Band Width: 9 kHz	s		
Test Results The requirements are:			
	minimum margin is 13.8 dE limit exceeded by maximur		MHz

## **Remarks**

See Appendix A for test data.

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### **Radiated Electric Field Emissions** 2.2

Test Date July 26, 2003				
Test Location  ☐ EMI-OATS: Testing v  EMI-OATS: Testing v				
Test Instruments  ☑ Field Strength Meter	-	Rohde & Schwarz	ESVS30	826638/008
Test Accessories  ☐ ULTRA Broadband Antenna ☐ Biconical Antenna ☐ Biconical Antenna ☐ Log-periodic Antenna		Schwarzbeck EMCO	HL562 BBA9106 3110B 3146	361324/014 41-00201 9607-2564 9607-4567
Frequency Range of 30 MHz to 1 GHz	f Meas	urement		
Instrument Settings IF Band Width: 120 kHz	s			
Test Results The requirements are:				
		m margin is 12.60 dBuV/ceeded by maximum of _		
Remarks				

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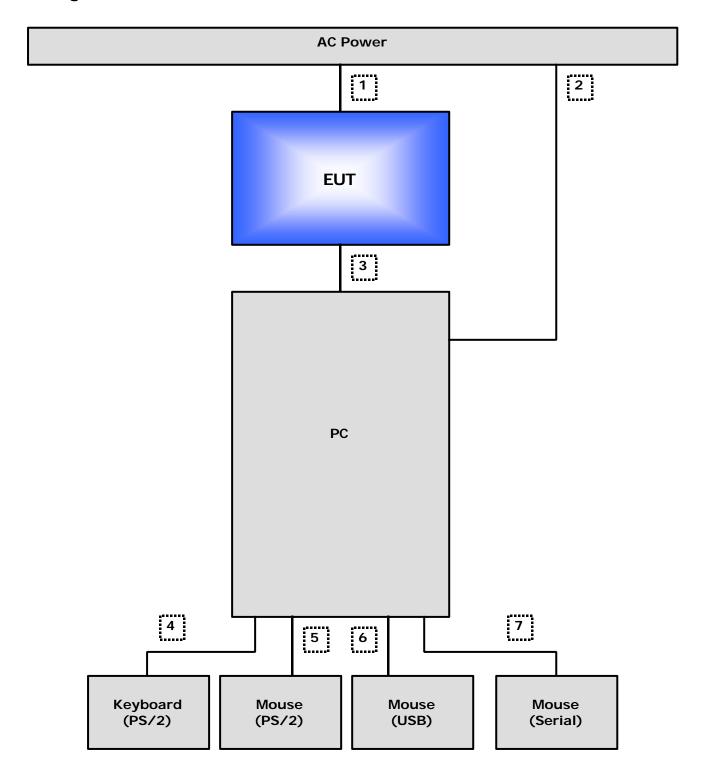
See Appendix A for test data

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# Configuration



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# APPENDIX A - TEST DATA

# Conducted Voltage Emissions (Quasi-Peak reading)

Frequency	Corre	ection			Quasi-peak				Ave	rage	
. ,	Fac	tor	Line	Limit	Reading	Result	Margin	Limit	Reading	Result	Margin
[MHz]	LISN	Cable		[dBuV]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
0.45	0.5	0.1	N	48.0	33.6	34.2	13.8				
0.83	0.3	0.1	L	48.0	24.8	25.2	22.8				
0.91	0.3	0.1	N	48.0	28.5	28.9	19.1				
1.36	0.3	0.1	N	48.0	25.1	25.5	22.6				
2.57	0.3	0.1	L	48.0	20.5	20.9	27.1				
3.40	0.3	0.1	N	48.0	19.2	19.6	28.4				
3.70	0.3	0.1	L	48.0	17.6	18.0	30.0				
5.06	0.3	0.1	N	48.0	17.0	17.4	30.6				
7.25	0.3	0.2	L	48.0	17.6	18.1	29.9				
7.40	0.3	0.2	N	48.0	19.0	19.5	28.5				
16.31	0.4	0.2	N	48.0	28.1	28.7	19.3				
21.01	0.7	0.4	L	48.0	27.8	28.9	19.1				

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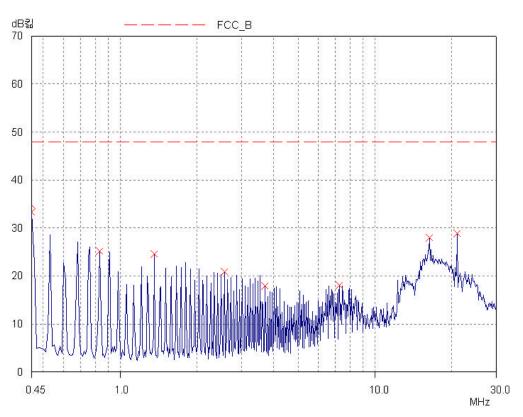
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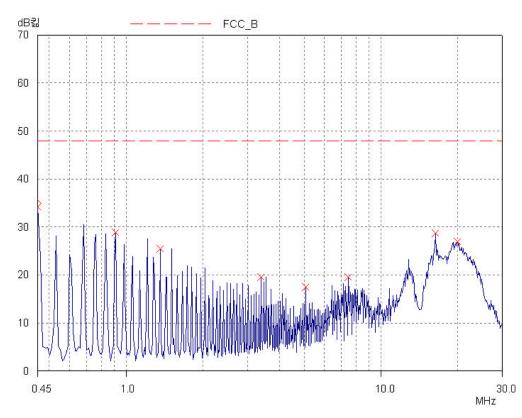


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Line



## Neutral



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# Radiated Electric Field Emissions (Quasi-Peak reading)

Frequency	Reading	Pol.	Height	Correction Factor		Limits	Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Cable	[dBuV/m]	[dBuV/m]	[dB]
113.42	18.6	Н	2.6	9.55	1.10	43.5	29.25	14.25
129.62	20.8	V	1.0	8.80	1.30	43.5	30.90	12.60
194.43	21.1	Н	1.2	7.00	1.70	43.5	29.80	13.70
210.63	14.7	V	1.0	7.70	1.80	43.5	24.20	19.30
469.86	14.0	V	1.0	15.00	3.30	46.0	32.30	13.70
506.51	10.9	Н	3.2	15.70	3.50	46.0	30.12	15.88
525.87	13.1	V	1.0	16.00	3.50	46.0	32.60	13.40
567.07	10.5	V	1.0	16.60	3.50	46.0	30.60	15.40

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